

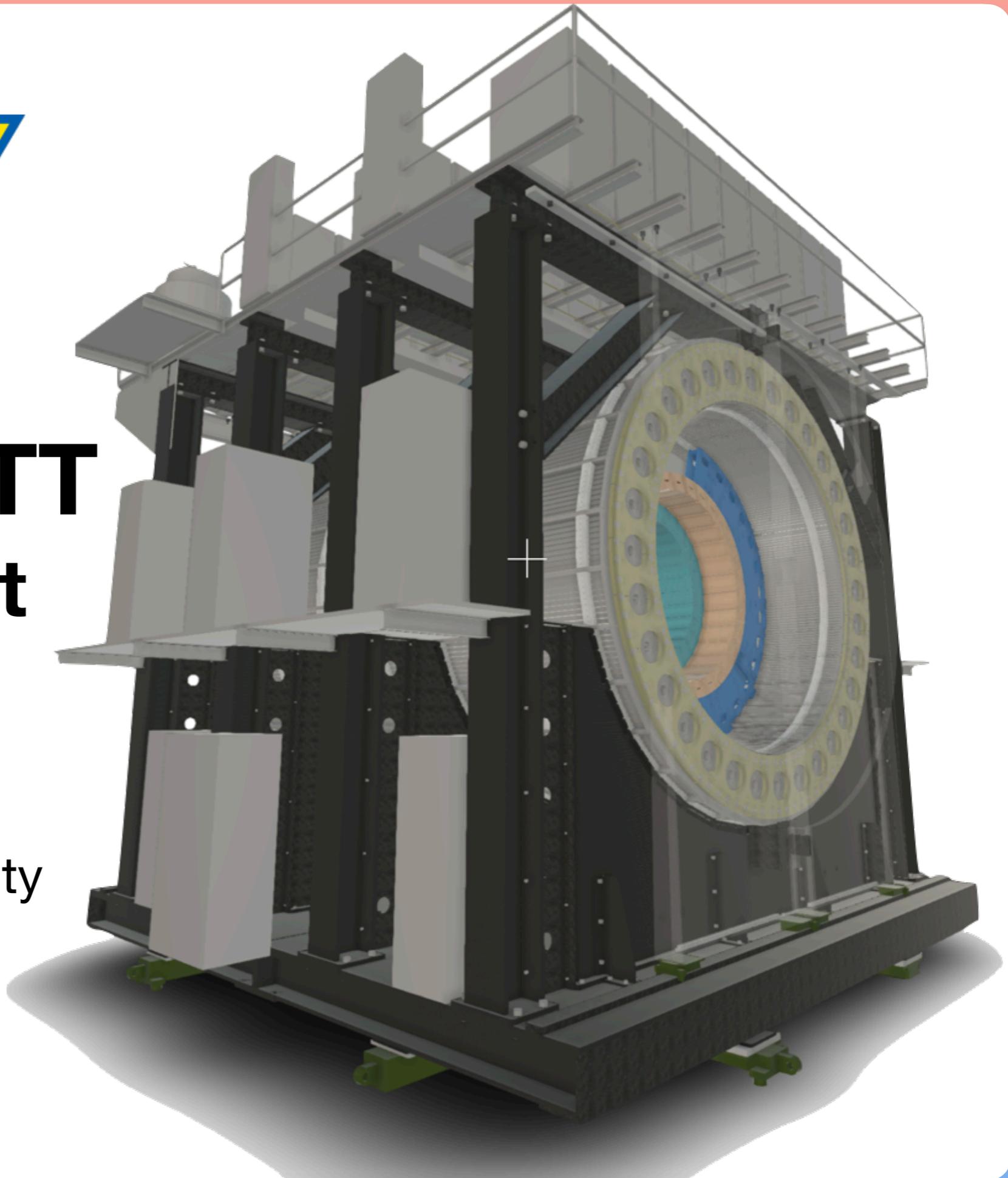


SPHENIX INTT - Weekly Report

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National Central University

2021/12/3



Assembly progress



Half-ladder assembly

	Total	Good	Not yet bonded & tested
Chip to HDI	4	2	2
Sensor to HDI	10	6	4
Encapsulation	1	1	0
Thermal cycle	16	16	0
On ladder	32	28	X

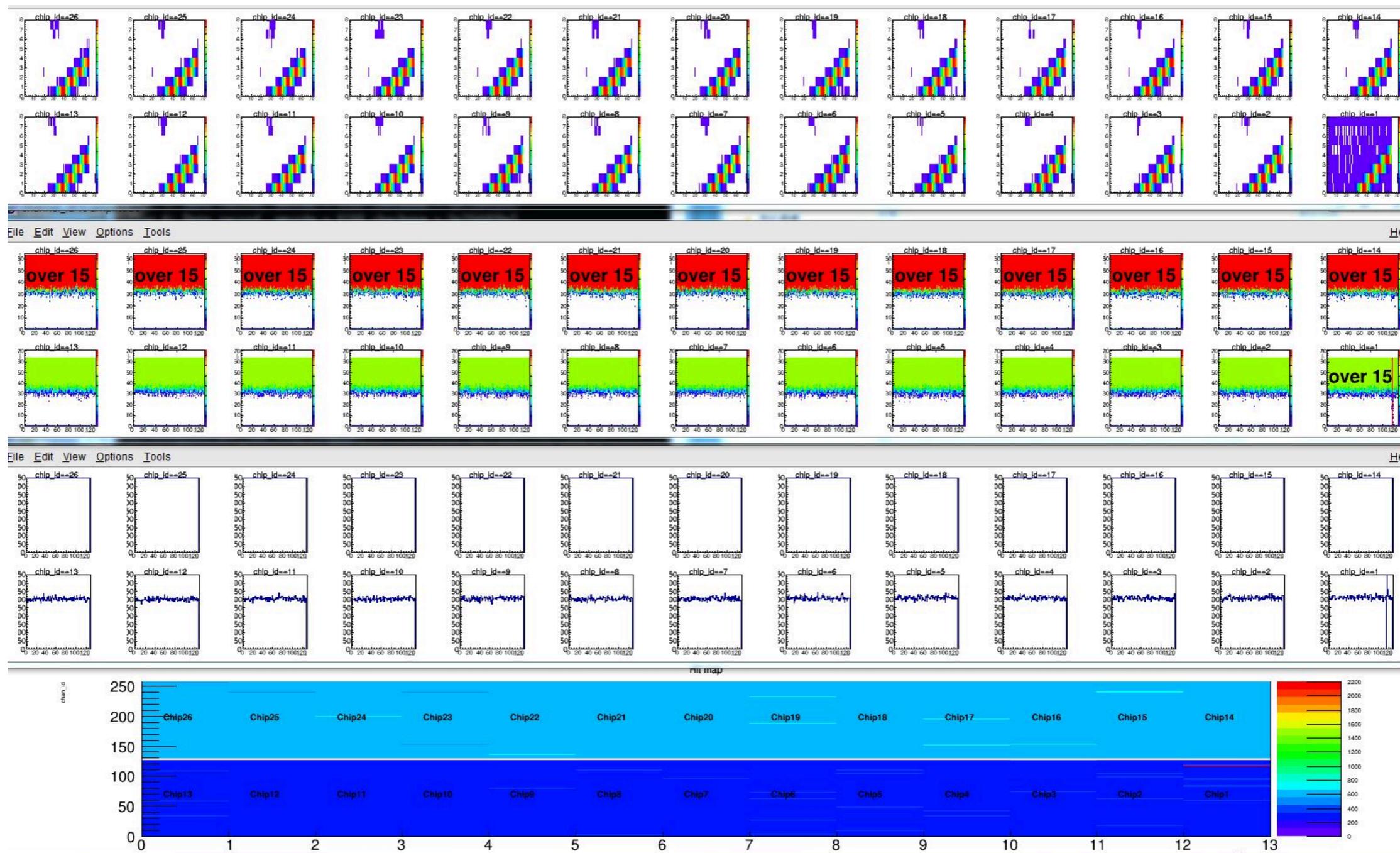
One in NWU

- We are about to move on to next ladder assembly session.
- We don't have space for new ladders.
- Ladder Source test campaign is scheduled to be started next week.
- Ladders will be sent to BNL after the Source test campaign.

Calibration, double entry



With long conversion cable

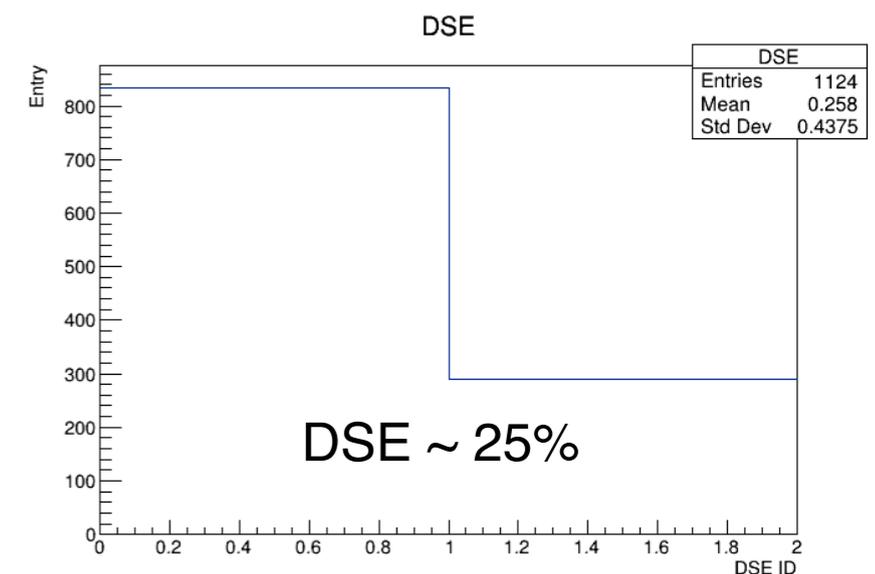


Does any facilities see this behavior before ?

Macro preparation for Testbeam2021



- Running options :
 - Layer alignment
 - Number of layer
 - 2 methods to choose the study chip (slot)
- Cut options :
 - $INTT_event = 1$ (coincidence signal of 3 sci + 1 INTT hit)
 - $camac_tdc6$ within a certain range
 - $camac_adc < a$ certain cut (optional)
 - Double saving event (DSE) (optional)
 - Golden track considered only (optional)
 - Pure hit track only (optional)



4 layers efficiency test



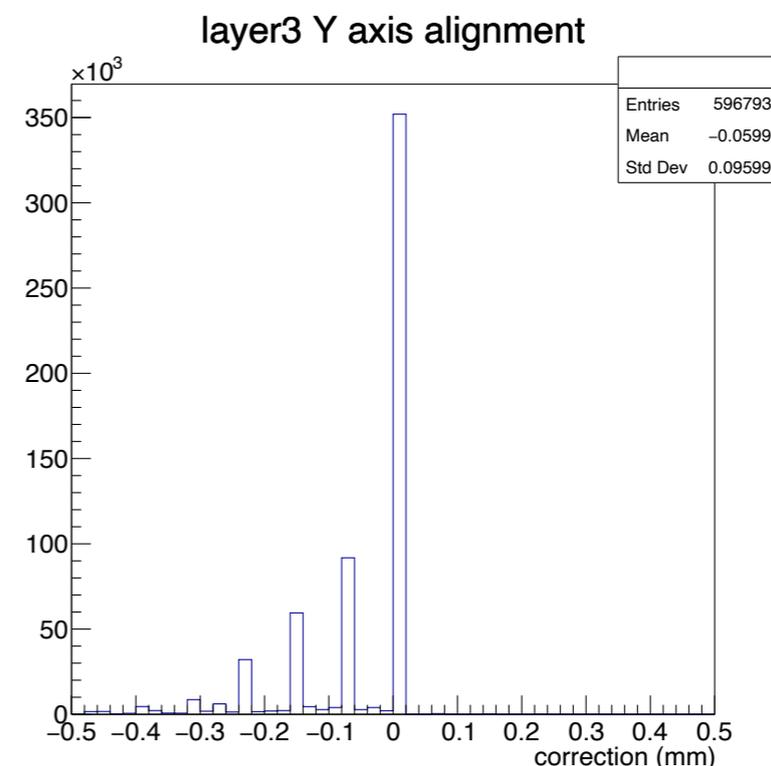
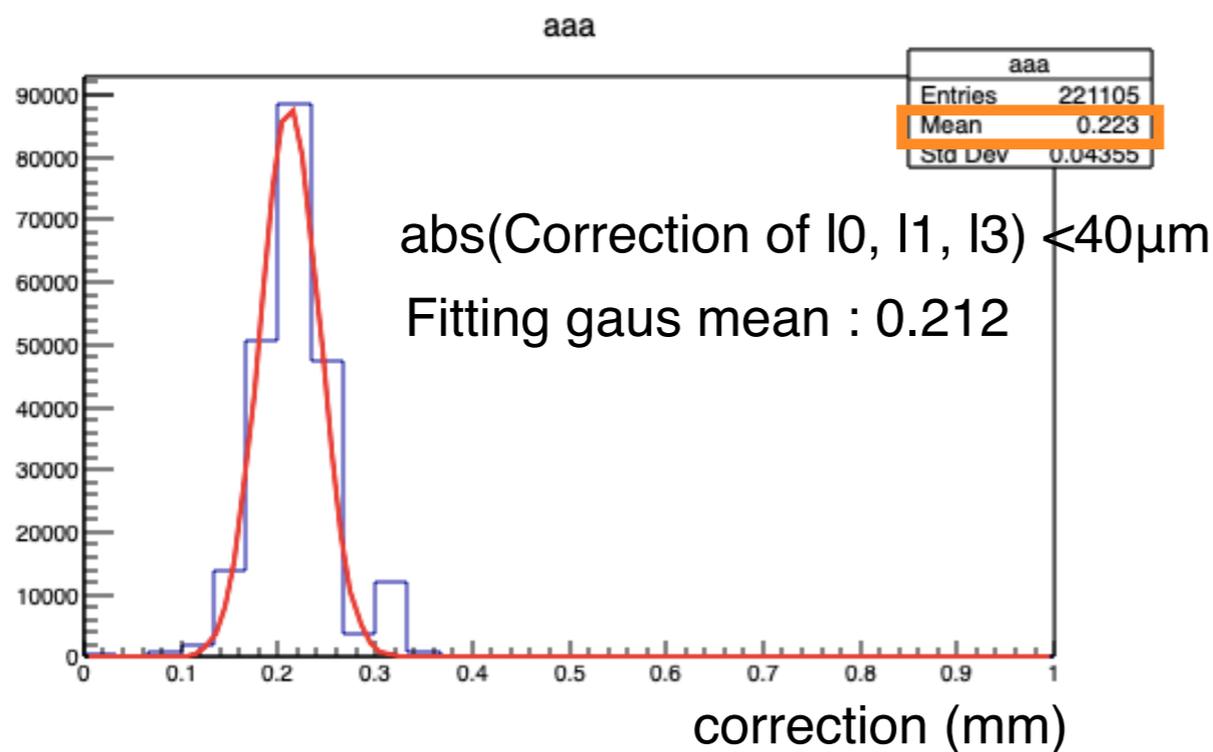
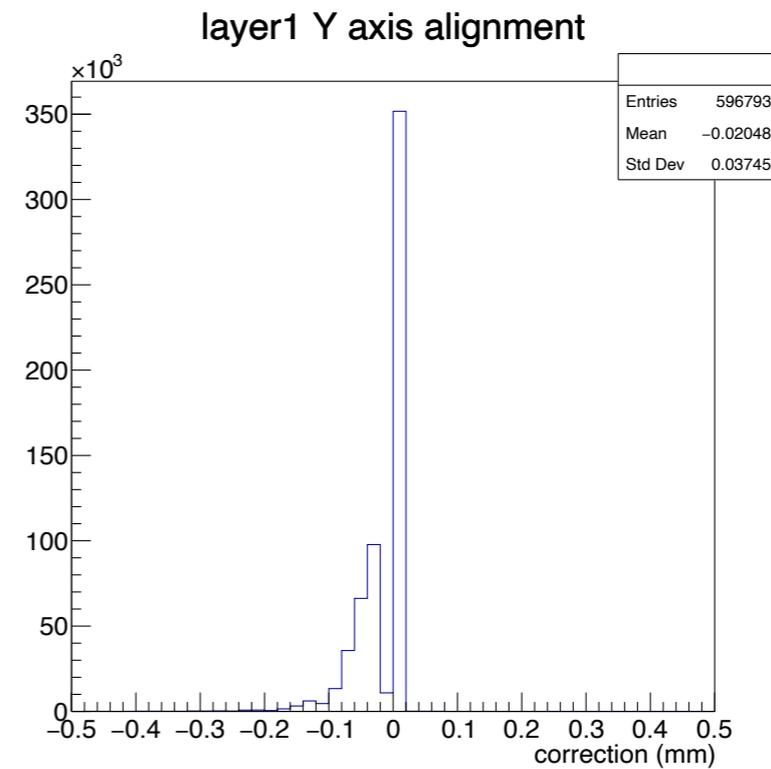
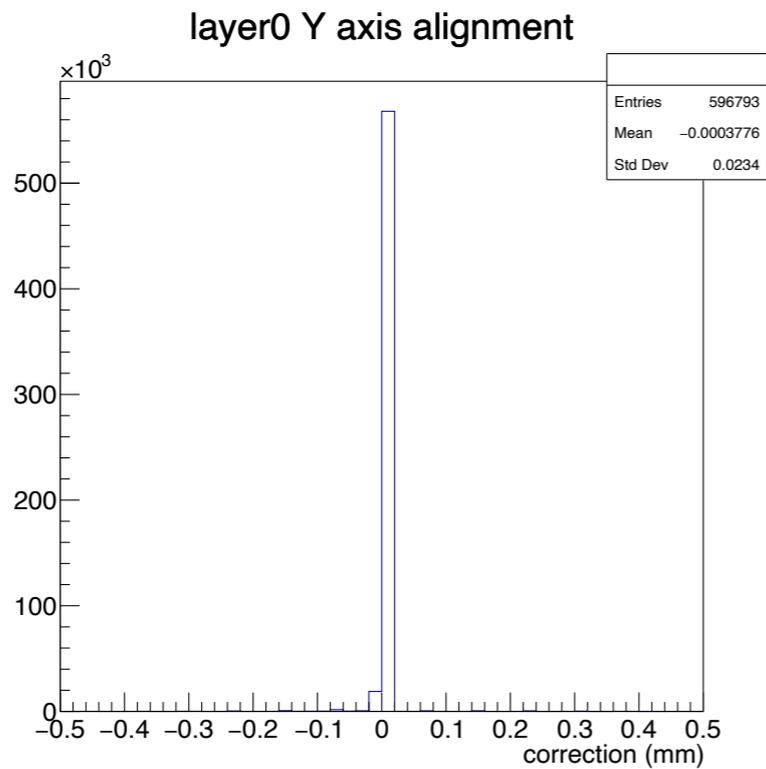
Efficiency of l1 is set to be 70% (30% of l1 data is deleted)

```
====4-layers====efficiency results=====  
|| l0 : 99.95875 %  
|| l1 : 71.09741 %  
|| l2 : 99.95017 %  
|| l3 : 99.79695 %  
====4-layers====efficiency results=====
```

Alignment results



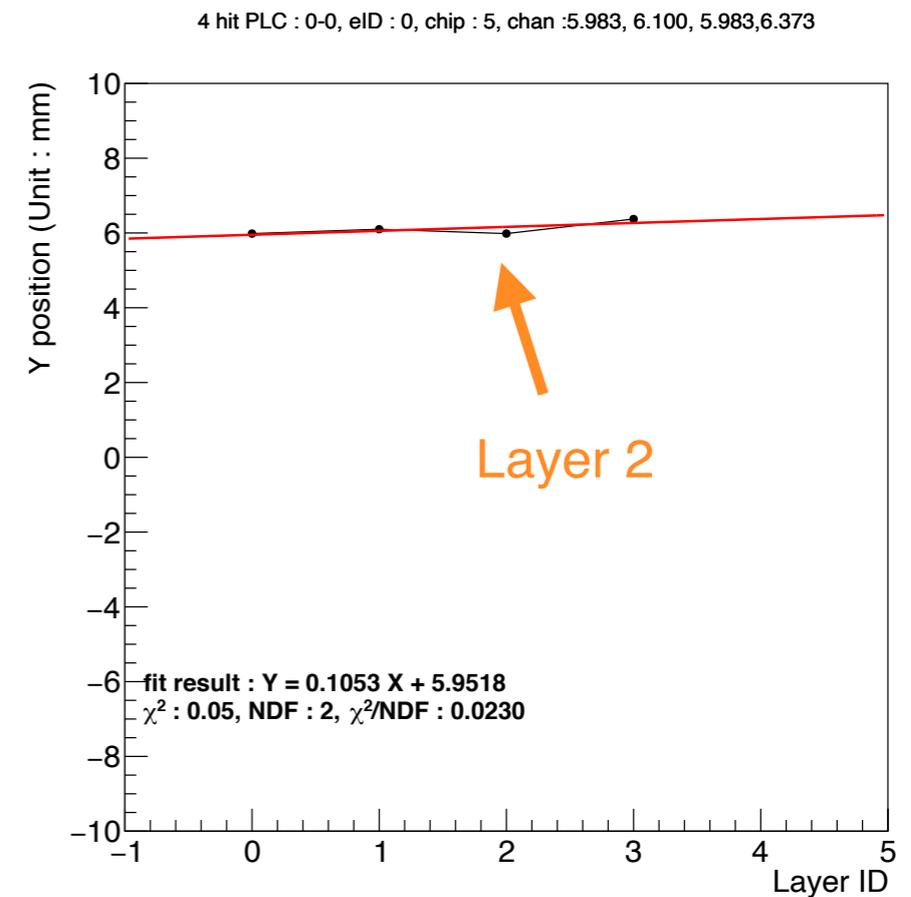
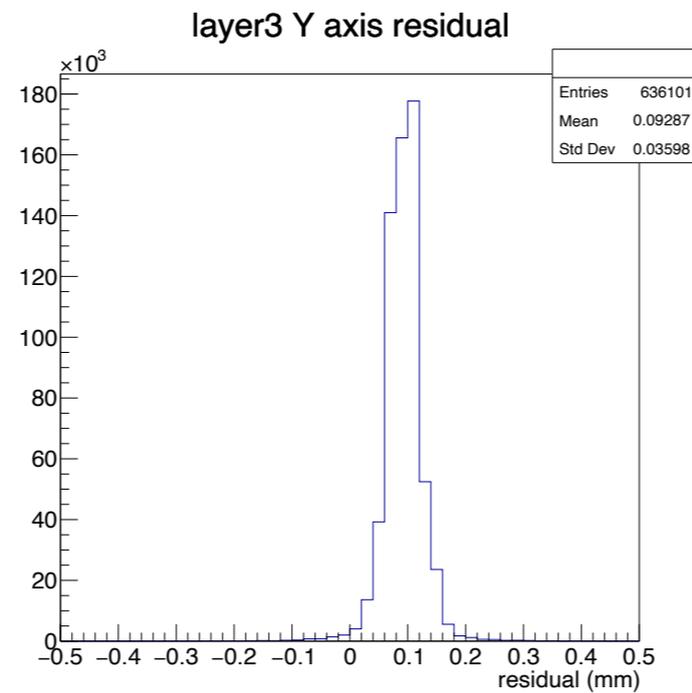
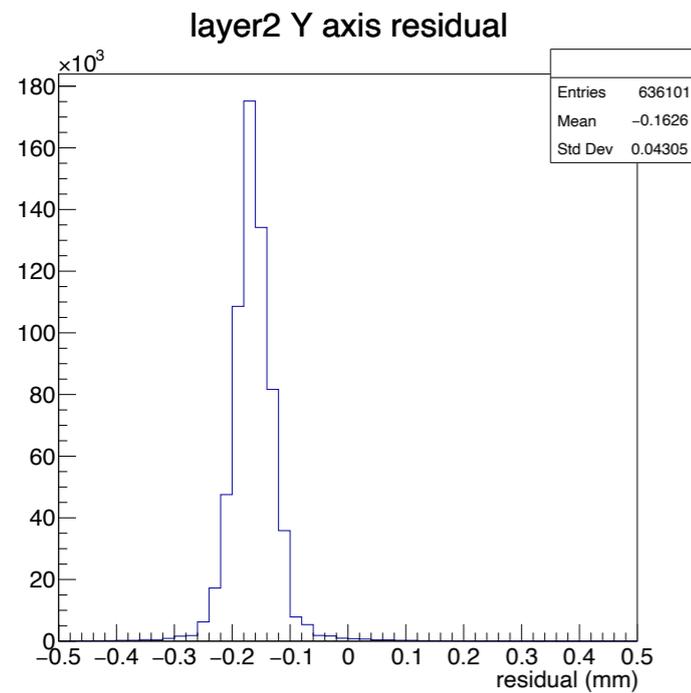
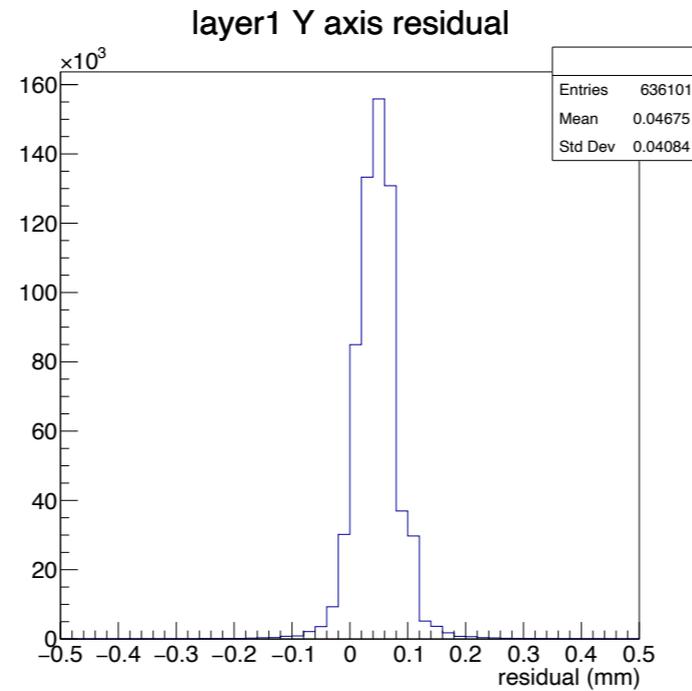
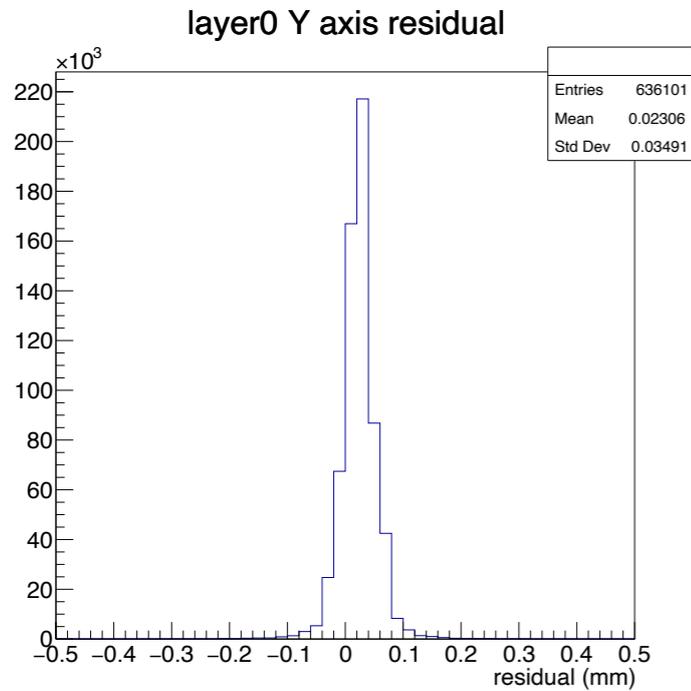
Ladder 2 has a + 234 μm offset in Y axis



Alignment results



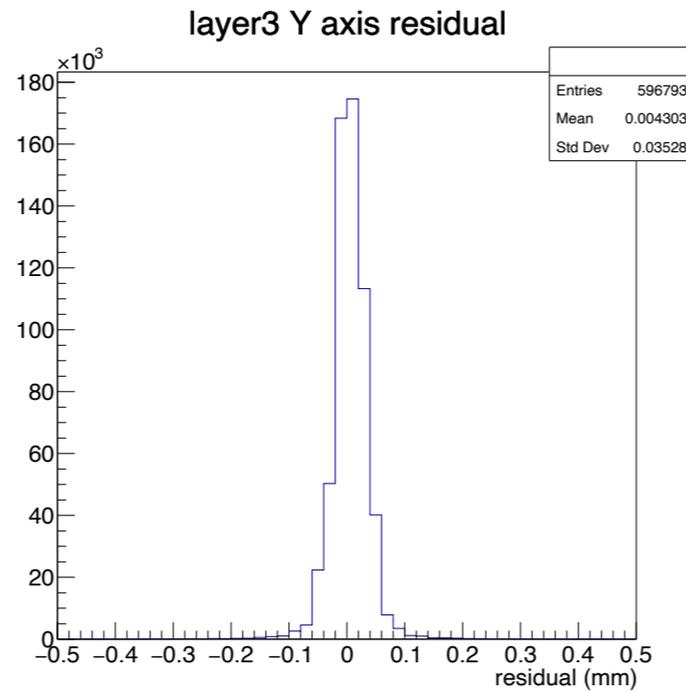
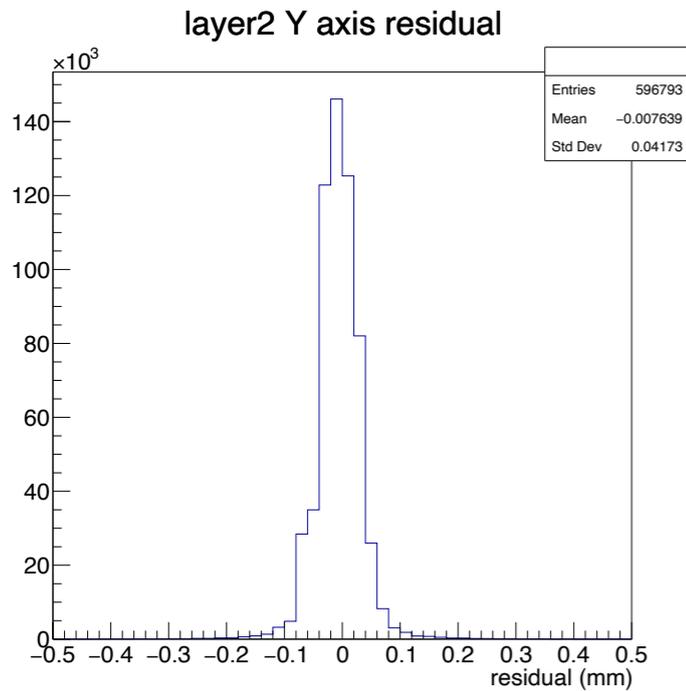
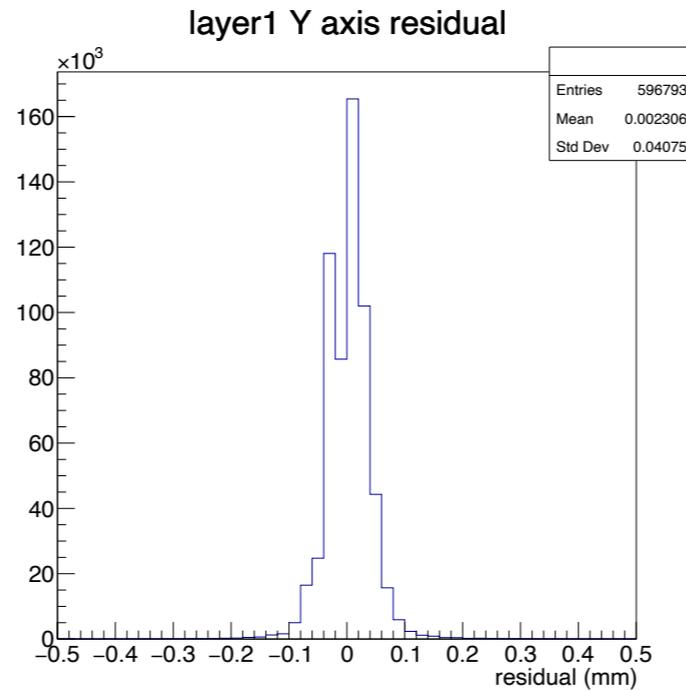
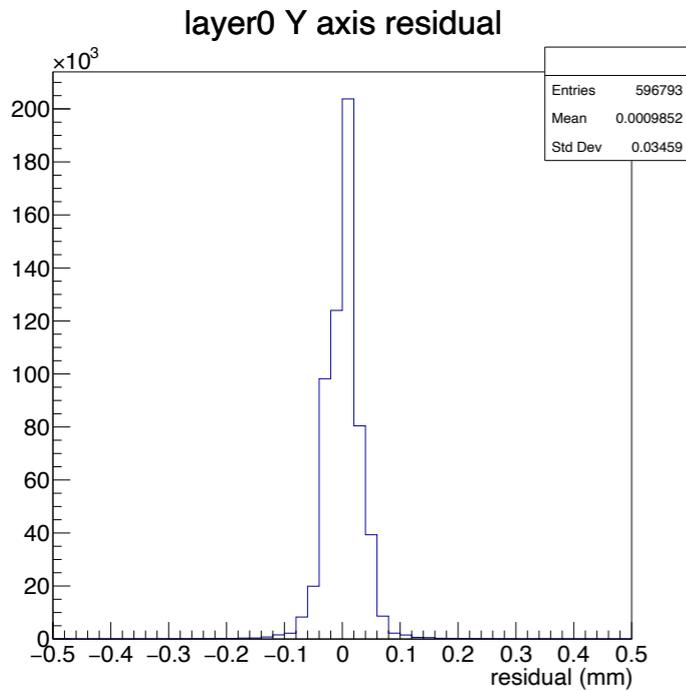
Ladder 2 has a + 234 μm offset in Y axis



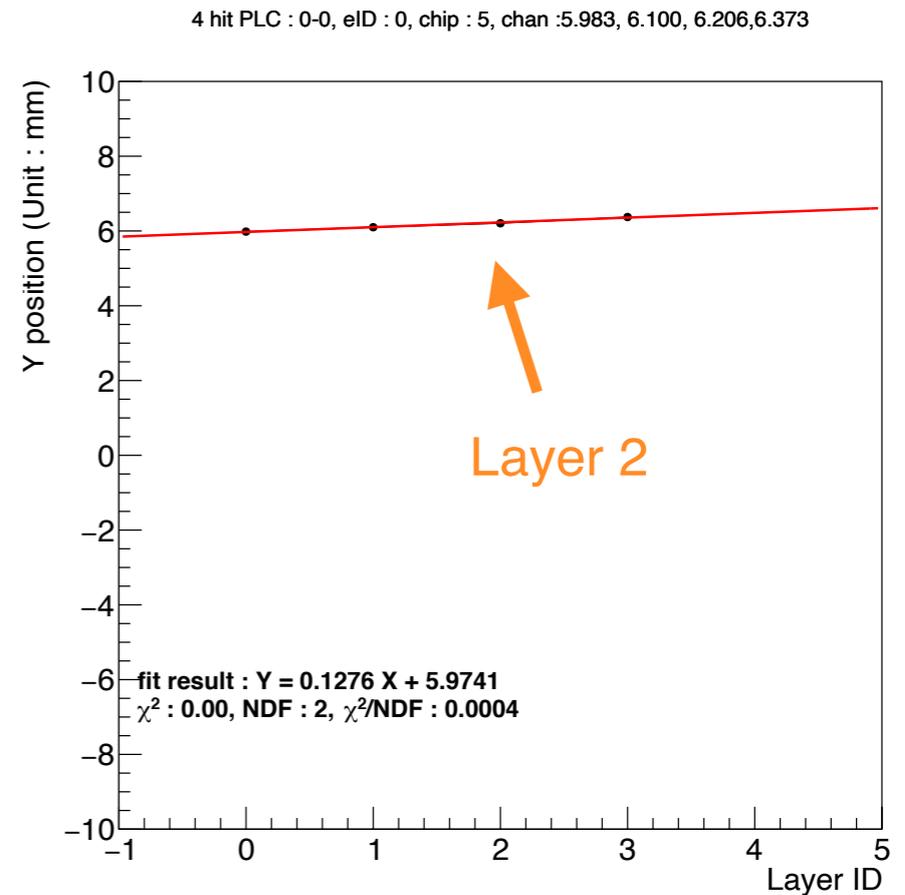
Alignment results add offset



Ladder 2 has a + 234 μm offset in Y axis



Layer2 - 0.223 mm



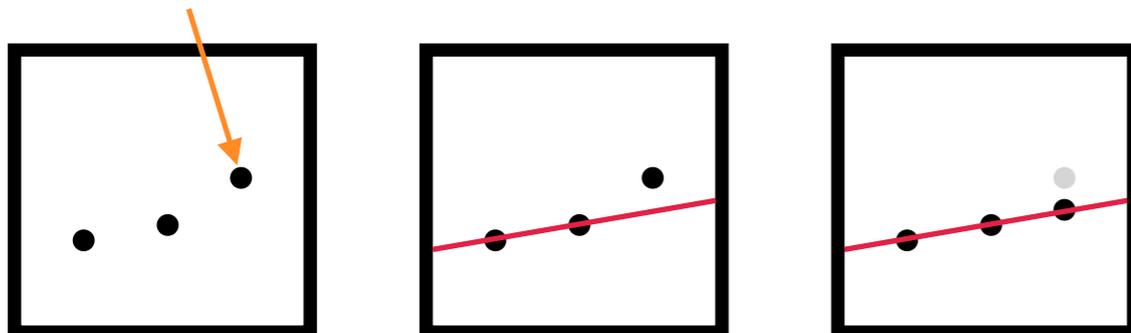
3 layers alignment

- Only 3 layers
- Efficiency of I0 is set to be 70%
- L2 has a + 234 μm offset in Y axis

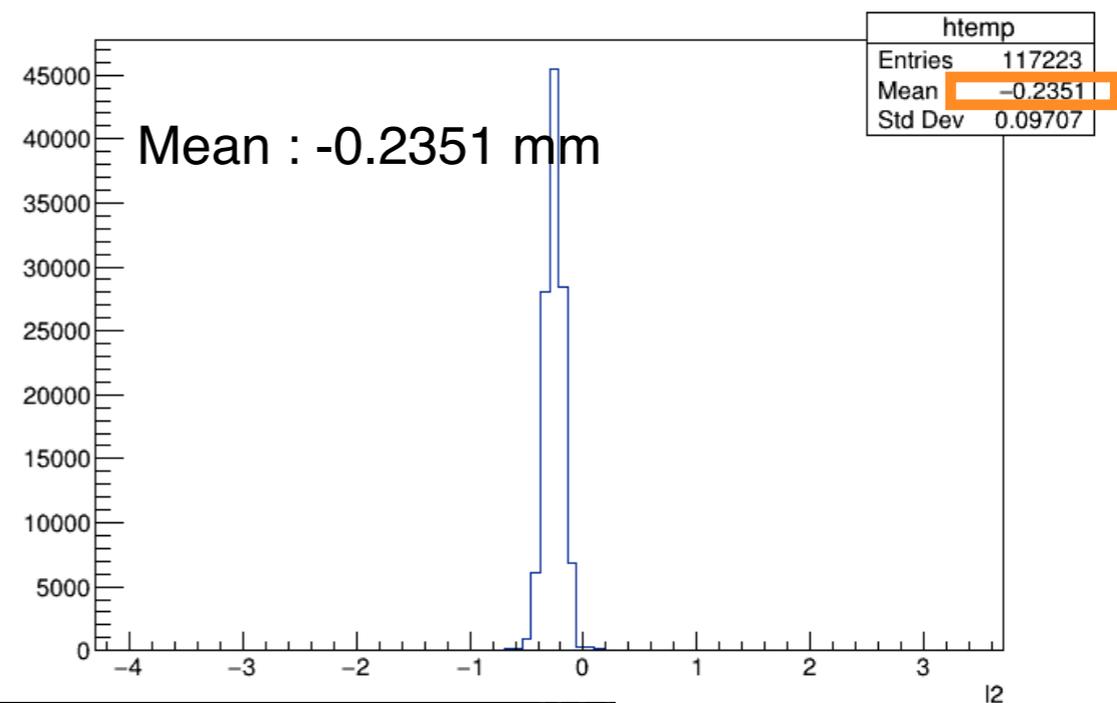
```
====3-layers====efficiency results====  
|| l0 : 74.64354 %  
|| l1 : 99.98891 %  
|| l2 : 99.93620 %  
====3-layers====efficiency results====
```

- The procedures to correct the layer position
 1. find out the outlier
 2. fit with the rest 2 points
 3. correct the outlier to this fitting line

Outlier



Amount of the correction of I2



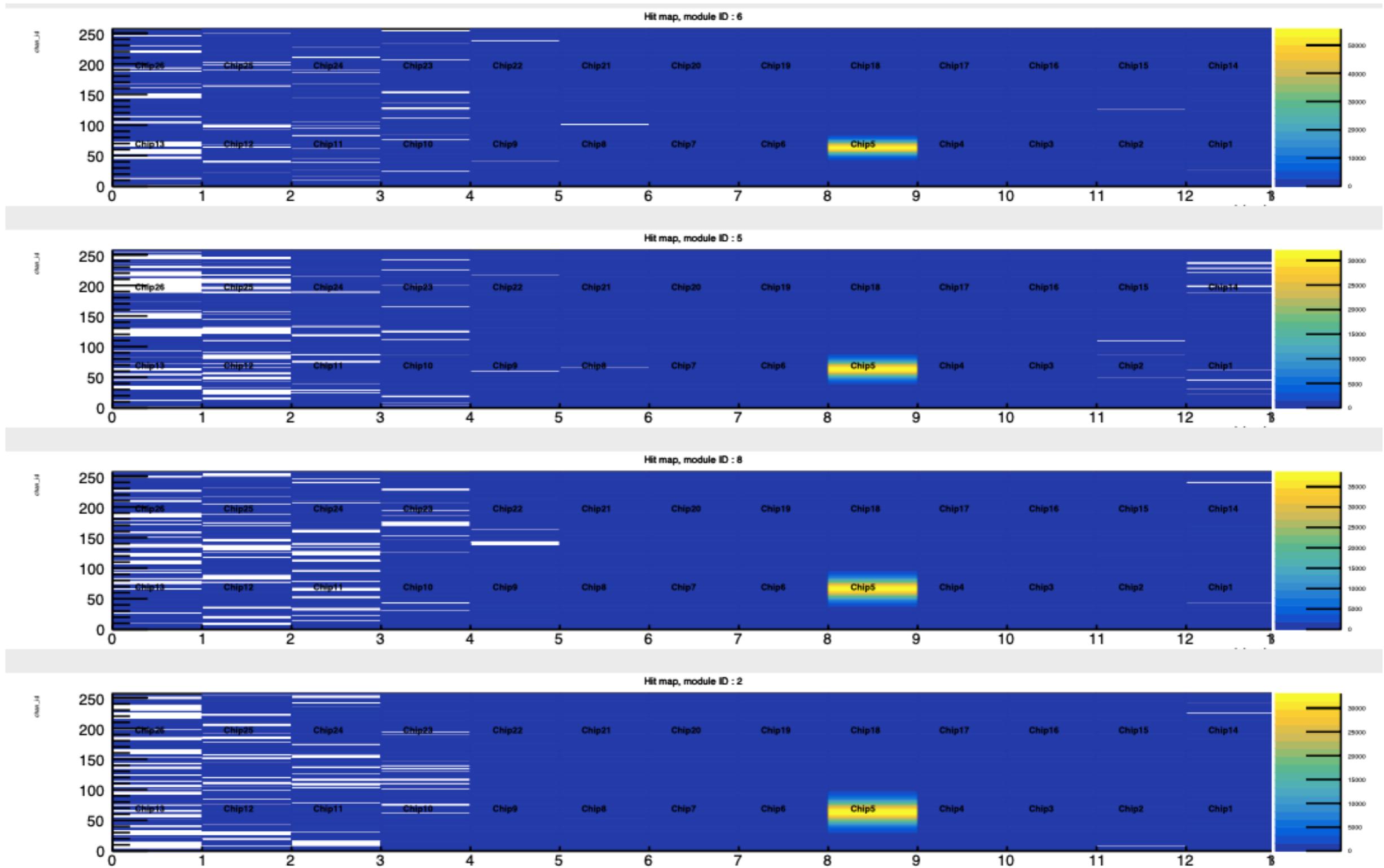
```
====3-layers====efficiency results====  
|| l0 : 71.88843 %  
|| l1 : 99.99143 %  
|| l2 : 99.94259 %  
====3-layers====efficiency results====
```

After adding the I2 correction back

The online monitoring plot



Hit map, demo with MC



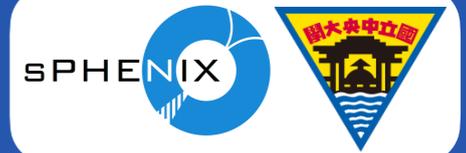
The online monitoring plot



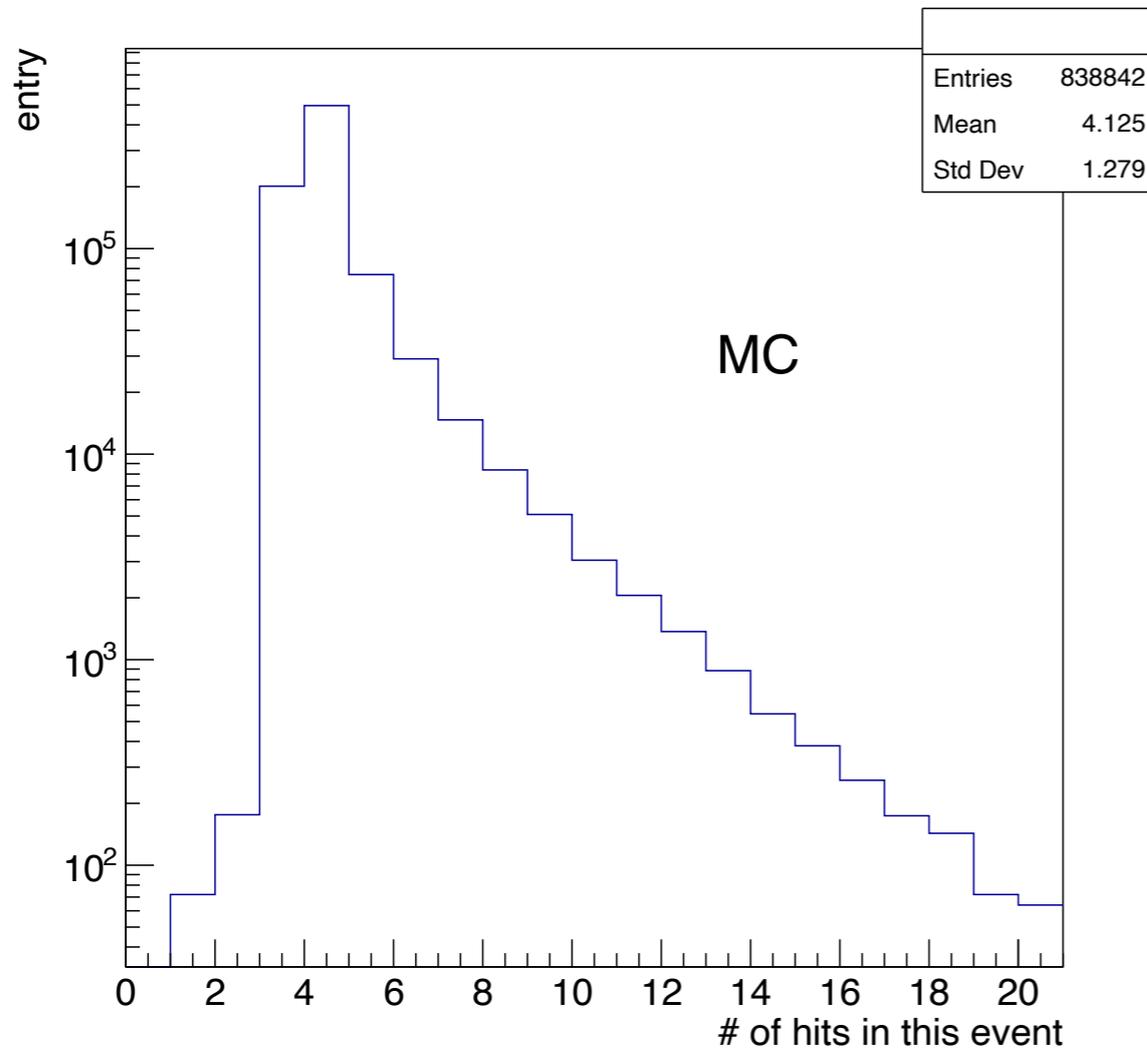
The chip adc distribution, demo with MC



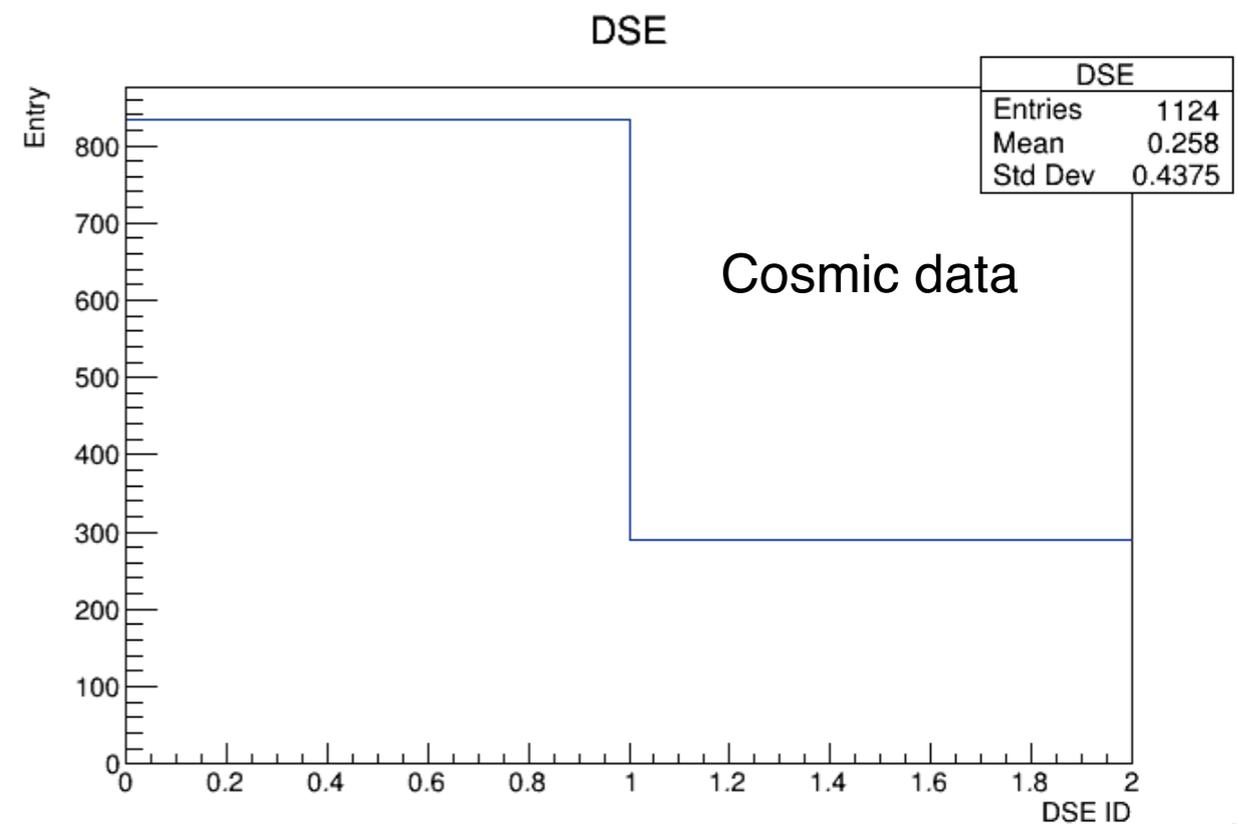
The online monitoring plot



event hit distribution



Double saving event



The peak should be at 4 as we have 4 layers ladder

Summary



- Lots of the cut options ✓
- Online monitoring plots ✓
- Efficiency for 3 or 4 layers ✓
- Alignment study for 3 or 4 layers ✓

- Ready for Testbeam !

- Next step :
 - Multi-tracks in one event

Back up



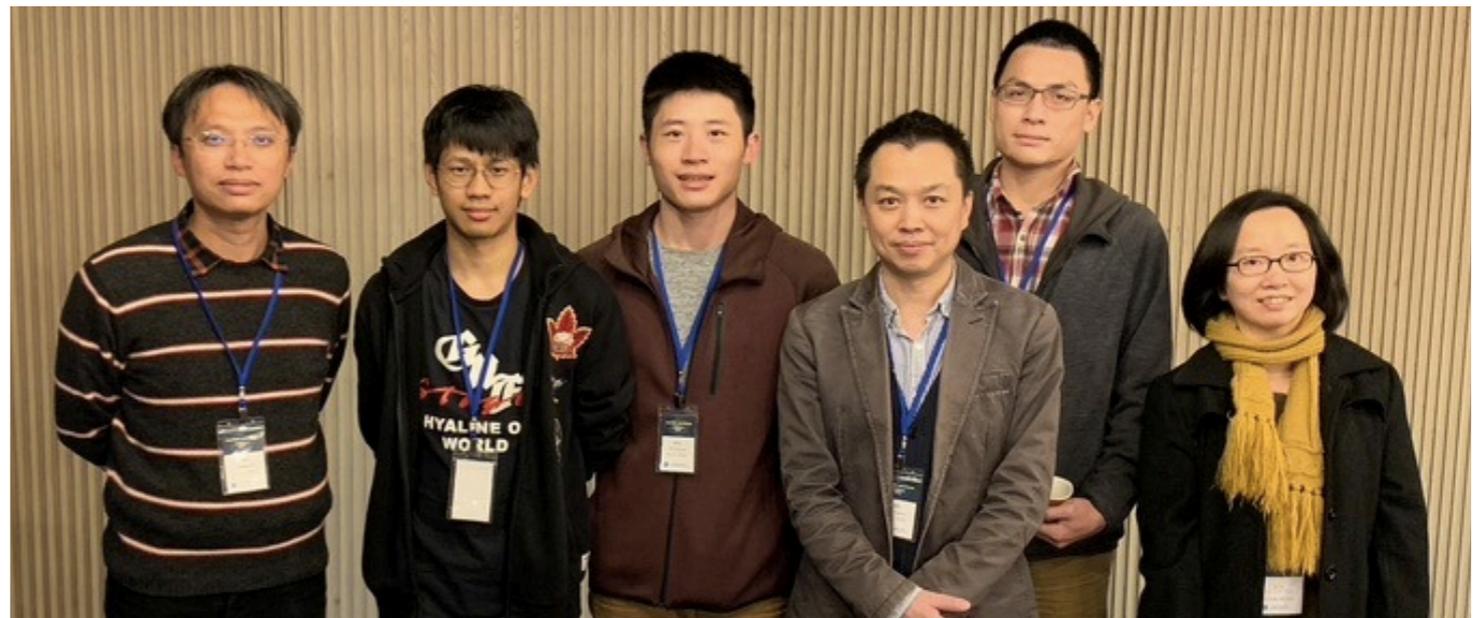
Taiwan INTT team



Ou-Wei Cheng



Kai-Yu Cheng



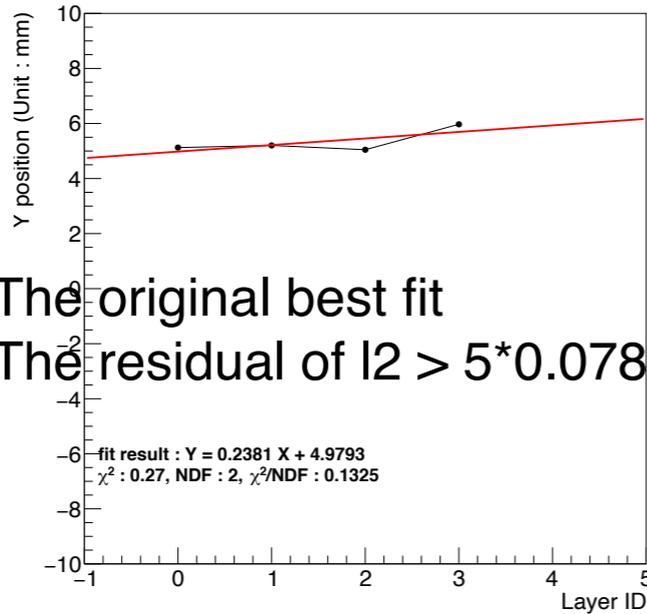
Chia-Ming Kuo Cheng-Wei Shih Lian-Sheng Tsai
Wei-Che Tang Rong-Shyang Lu Jenny Huang

Event profile example

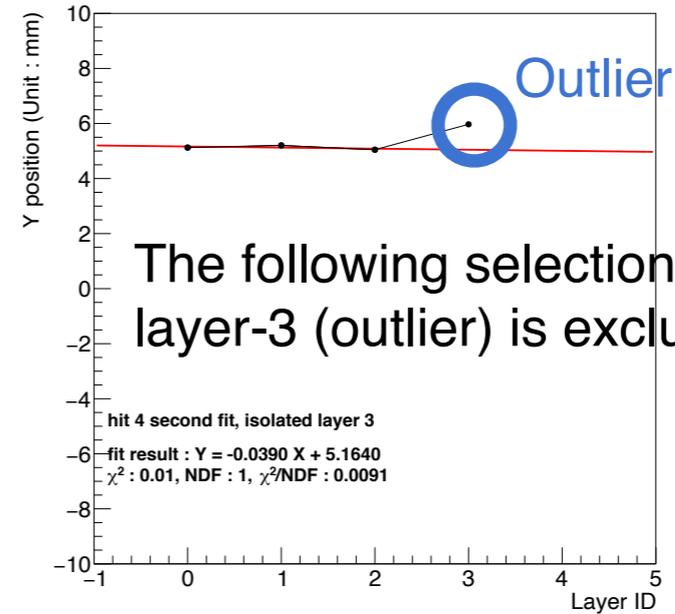


Example of event profile : 1110

4 hit PLC : 1864-0, eID : 2207, chip : 5, chan : 5.125, 5.203, 5.047, 5.971



4 hit PLC : 1864, eID : 2207, chip : 5, chan : 5.125, 5.203, 5.047, 5.971



```

*****
*   Row   * Instance * camac_adc * camac_tdc * INTT_even * module * chip_id * chan_id * adc * nele * DSE * eID *
*****
*   2207 *      0 *    45 *    152 *      1 *     6 *    5 *    62 *    3 *  22 *  0 * 2207 *
*   2207 *      1 *    99 *    140 *      1 *     5 *    5 *    61 *    3 *  22 *  0 * 2207 *
*   2207 *      2 *    92 *    132 *      1 *     8 *    5 *    63 *    5 *  22 *  0 * 2207 *
*   2207 *      3 *      *      0 *      1 *     2 *    5 *    41 *    1 *  22 *  0 * 2207 *
*   2207 *      4 *      *      0 *      1 *     2 *    5 *    42 *    1 *  22 *  0 * 2207 *
*   2207 *      5 *      *   882 *      1 *     2 *    5 *    43 *    1 *  22 *  0 * 2207 *
*   2207 *      6 *      *      *      1 *     2 *    5 *    44 *    0 *  22 *  0 * 2207 *
*   2207 *      7 *      *      *      1 *     2 *    5 *    45 *    0 *  22 *  0 * 2207 *
*   2207 *      8 *      *      *      1 *     2 *    5 *    46 *    0 *  22 *  0 * 2207 *
*   2207 *      9 *      *      *      1 *     2 *    5 *    47 *    1 *  22 *  0 * 2207 *
*   2207 *     10 *      *      *      1 *     2 *    5 *    48 *    0 *  22 *  0 * 2207 *
*   2207 *     11 *      *      *      1 *     2 *    5 *    49 *    0 *  22 *  0 * 2207 *
*   2207 *     12 *      *      *      1 *     2 *    5 *    50 *    0 *  22 *  0 * 2207 *
*   2207 *     13 *      *      *      1 *     2 *    5 *    51 *    1 *  22 *  0 * 2207 *
*   2207 *     14 *      *      *      1 *     2 *    5 *    52 *    1 *  22 *  0 * 2207 *
*   2207 *     15 *      *      *      1 *     2 *    5 *    53 *    0 *  22 *  0 * 2207 *
*   2207 *     16 *      *      *      1 *     2 *    5 *    54 *    1 *  22 *  0 * 2207 *
*   2207 *     17 *      *      *      1 *     2 *    5 *    55 *    1 *  22 *  0 * 2207 *
*   2207 *     18 *      *      *      1 *     2 *    5 *    56 *    1 *  22 *  0 * 2207 *
*   2207 *     19 *      *      *      1 *     2 *    5 *    57 *    1 *  22 *  0 * 2207 *
*   2207 *     20 *      *      *      1 *     2 *    5 *    58 *    1 *  22 *  0 * 2207 *
*   2207 *     21 *      *      *      1 *     2 *    5 *    59 *    3 *  22 *  0 * 2207 *
*****
    
```

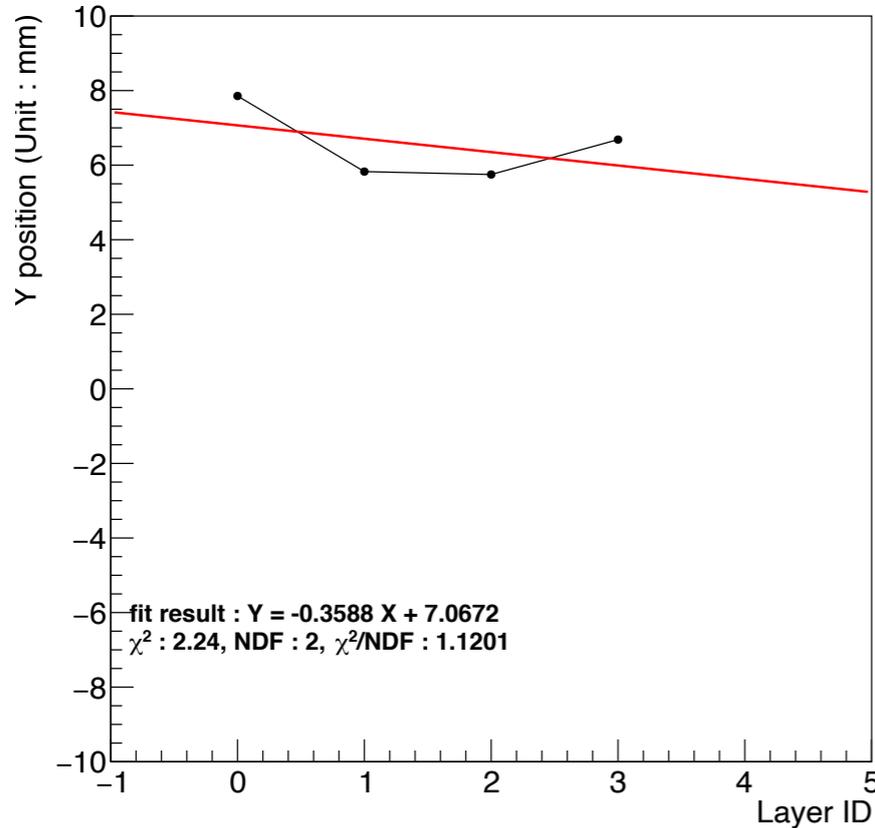
Same cluster !

Event profile example



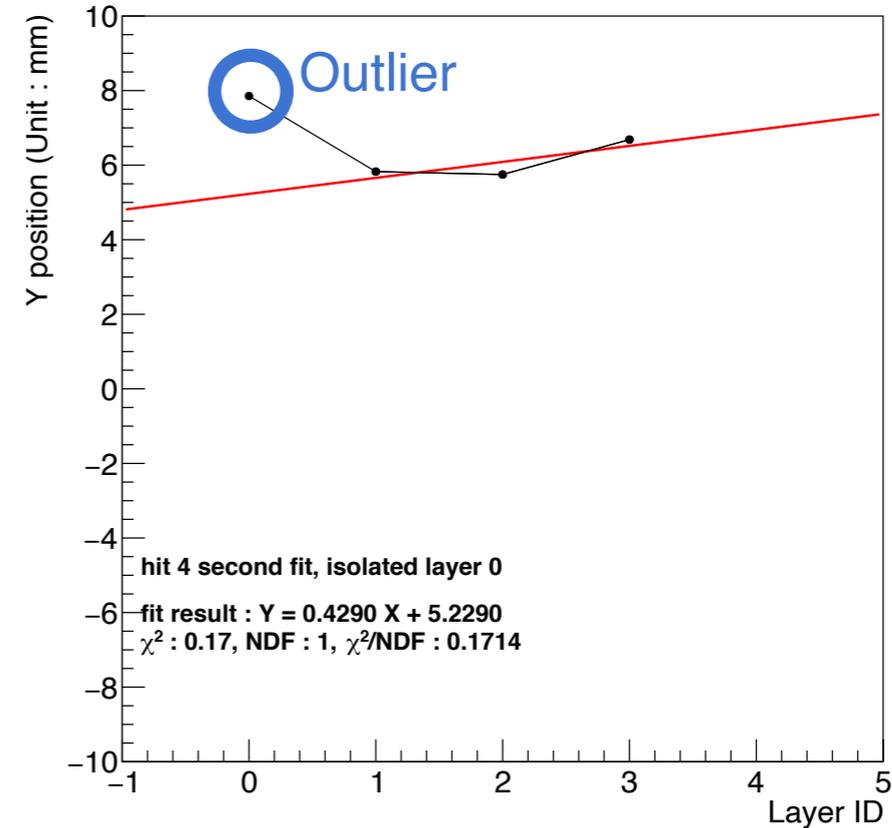
Example of event profile : 0111

4 hit PLC : 5965-0, eID : 7092, chip : 5, chan :7.855, 5.827, 5.749,6.685



The original best fit
 The residual of l1 > 5*0.078mm

4 hit PLC : 5965, eID : 7092, chip : 5, chan :7.855, 5.827, 5.749,6.685



The following selection, layer-0 (outlier) is excluded

```
[root [1] tree_both->Scan("camac_adc:camac_tdc:INTT_event:module:chip_id:chan_id:adc:nele:DSE:eID","eID==7092")
*****
*   Row   * Instance * camac_adc * camac_tdc * INTT_even *   module *   chip_id *   chan_id *   adc *   nele *   DSE *   eID *
*****
*   7092 *         0 *      47 *    159 *         1 *         6 *         5 *        27 *         3 *         4 *         0 *   7092 *
*   7092 *         1 *     100 *    140 *         1 *         5 *         5 *        53 *         3 *         4 *         0 *   7092 *
*   7092 *         2 *     101 *    138 *         1 *         8 *         5 *        54 *         3 *         4 *         0 *   7092 *
*   7092 *         3 *         *         0 *         1 *         2 *         5 *        42 *         2 *         4 *         0 *   7092 *
*   7092 *         4 *         *         0 *         1 *         *         *         *         *         4 *         0 *   7092 *
*   7092 *         5 *         *      821 *         1 *         *         *         *         *         4 *         0 *   7092 *
*****
```

Other examples of rejected event



Too large adc

```
root [1] tree_both->Scan("camac_adc:camac_tdc:INTT_event:module:chip_id:chan_id:adc:nele:DSE:eID","eID==8000")
*****
*   Row   * Instance * camac_adc * camac_tdc * INTT_event * module * chip_id * chan_id * adc * nele * DSE * eID *
*****
*   8000 *     0 *     45 *     178 *     1 *     6 *     5 *     67 *     4 *     9 *     0 * 8000 *
*   8000 *     1 *     169 *     141 *     1 *     5 *     5 *     68 *     6 *     9 *     0 * 8000 *
*   8000 *     2 *    1834 *     158 *     1 *     8 *     5 *     69 *     3 *     9 *     0 * 8000 *
*   8000 *     3 *     *     0 *     1 *     2 *     5 *     69 *     3 *     9 *     0 * 8000 *
*   8000 *     4 *     *     0 *     1 *     2 *     5 *     70 *     3 *     9 *     0 * 8000 *
*   8000 *     5 *     *     886 *     1 *     2 *     5 *     71 *     1 *     9 *     0 * 8000 *
*   8000 *     6 *     *     *     1 *     2 *     5 *     72 *     0 *     9 *     0 * 8000 *
*   8000 *     7 *     *     *     1 *     2 *     5 *     73 *     0 *     9 *     0 * 8000 *
*   8000 *     8 *     *     *     1 *     2 *     5 *     74 *     1 *     9 *     0 * 8000 *
*****
```

Only 1 hit

```
*****
*   Row   * Instance * camac_adc * camac_tdc * INTT_event * module * chip_id * chan_id * adc * nele * DSE * eID *
*****
*   5855 *     0 *     45 *     165 *     1 *     2 *     5 *     29 *     3 *     1 *     0 * 5855 *
*   5855 *     1 *     99 *     140 *     1 *     *     *     *     *     1 *     0 * 5855 *
*   5855 *     2 *     94 *     145 *     1 *     *     *     *     *     1 *     0 * 5855 *
*   5855 *     3 *     *     0 *     1 *     *     *     *     *     1 *     0 * 5855 *
*   5855 *     4 *     *     0 *     1 *     *     *     *     *     1 *     0 * 5855 *
*   5855 *     5 *     *     909 *     1 *     *     *     *     *     1 *     0 * 5855 *
*****
```

Only 1 cluster

```
*****
*   Row   * Instance * camac_adc * camac_tdc * INTT_event * module * chip_id * chan_id * adc * nele * DSE * eID *
*****
*  11244 *     0 *     54 *     146 *     1 *     6 *     5 *     92 *     5 *     2 *     0 * 11244 *
*  11244 *     1 *     146 *     139 *     1 *     2 *     6 *     109 *     3 *     2 *     0 * 11244 *
*  11244 *     2 *     111 *     126 *     1 *     *     *     *     *     2 *     0 * 11244 *
*  11244 *     3 *     *     0 *     1 *     *     *     *     *     2 *     0 * 11244 *
*  11244 *     4 *     *     0 *     1 *     *     *     *     *     2 *     0 * 11244 *
*  11244 *     5 *     *     843 *     1 *     *     *     *     *     2 *     0 * 11244 *
*****
```

Issue of double saving event



MC → interface macro → filter macro → tracking ana macro
 TestBeam → filter macro → tracking ana macro

Interface macro : to convert the MC data format into TestBeam data format
 filter macro : to filter the double saving hits in each event.

Some hits seem to be recorded twice : 1<->3, 2<->4, 5<->7 and 6 <-> 8. I think it is ok as long as both are identical.

one event
real data

```

*****
* Row * Instance * event * chip_id * chan_id * module * adc * bco * bco_full * camac_tdc * camac_adc * INTT_even *
*****
* 17 * 0 * -1 * 22 * 84 * 6 * 2 * 111 * 62063 * 138 * 204 * 1 *
* 17 * 1 * -1 * 22 * 83 * 6 * 1 * 111 * 62063 * 140 * 206 * 1 *
* 17 * 2 * -1 * 22 * 85 * 6 * 1 * 111 * 62063 * 167 * 245 * 1 *
* 17 * 3 * -1 * 22 * 83 * 6 * 1 * 112 * 62064 * 0 * * 1 *
* 17 * 4 * -1 * 22 * 85 * 6 * 1 * 112 * 62064 * 0 * * 1 *
* 17 * 5 * -1 * 21 * 103 * 5 * 7 * 113 * 62065 * 676 * * 1 *
* 17 * 6 * -1 * 16 * 0 * 5 * 0 * 113 * 62065 * * * 1 *
* 17 * 7 * -1 * 21 * 103 * 5 * 7 * 114 * 62066 * * * 1 *
* 17 * 8 * -1 * 16 * 0 * 5 * 0 * 114 * 62066 * * * 1 *
    
```

But if you check another event shown below, you can see there is one hit recorded twice but with different adc....

one event
real data

```

*****
* Row * Instance * event * chip_id * chan_id * module * adc * bco * bco_full * camac_tdc * camac_adc * INTT_even *
*****
* 11 * 0 * -1 * 21 * 127 * 5 * 7 * 90 * 53850 * 156 * 161 * 1 *
* 11 * 1 * -1 * 21 * 126 * 5 * 1 * 90 * 53850 * 140 * 212 * 1 *
* 11 * 2 * -1 * 21 * 126 * 5 * 7 * 90 * 53850 * 132 * 379 * 1 *
* 11 * 3 * -1 * 5 * 107 * 6 * 2 * 90 * 53850 * 0 * * 1 *
* 11 * 4 * -1 * 21 * 8 * 5 * 7 * 90 * 53850 * 0 * * 1 *
Type <CR> to continue or q to quit ==>
* 11 * 5 * -1 * 21 * 120 * 5 * 3 * 90 * 53850 * 600 * * 1 *
* 11 * 6 * -1 * 21 * 5 * 5 * 2 * 90 * 53850 * * * 1 *
* 11 * 7 * -1 * 16 * 0 * 5 * 0 * 90 * 53850 * * * 1 *
* 11 * 8 * -1 * 21 * 66 * 5 * 6 * 91 * 53851 * * * 1 *
* 11 * 9 * -1 * 16 * 0 * 5 * 0 * 91 * 53851 * * * 1 *
    
```

It will effect on tracking result as the energy-weighted method is applied.

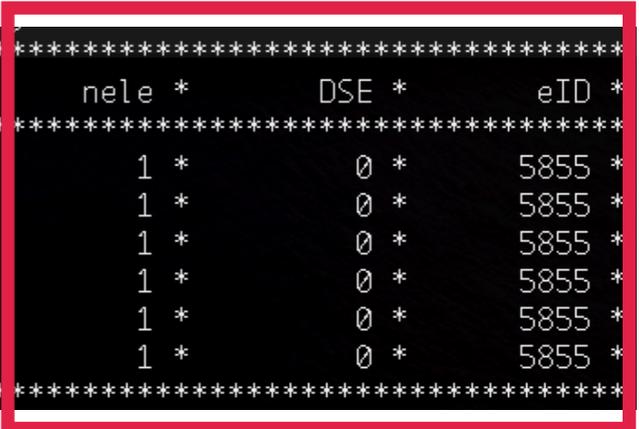
Macro preparation for Testbeam2021



- 3 added branches in filter_N_v3.c makes the analysis easier
 - nele : number of element in the this event (vector)
 - DSE : double saving event indicator
 - If double saving event appears, DSE = 1, else DSE = 0
 - eID : event ID

```

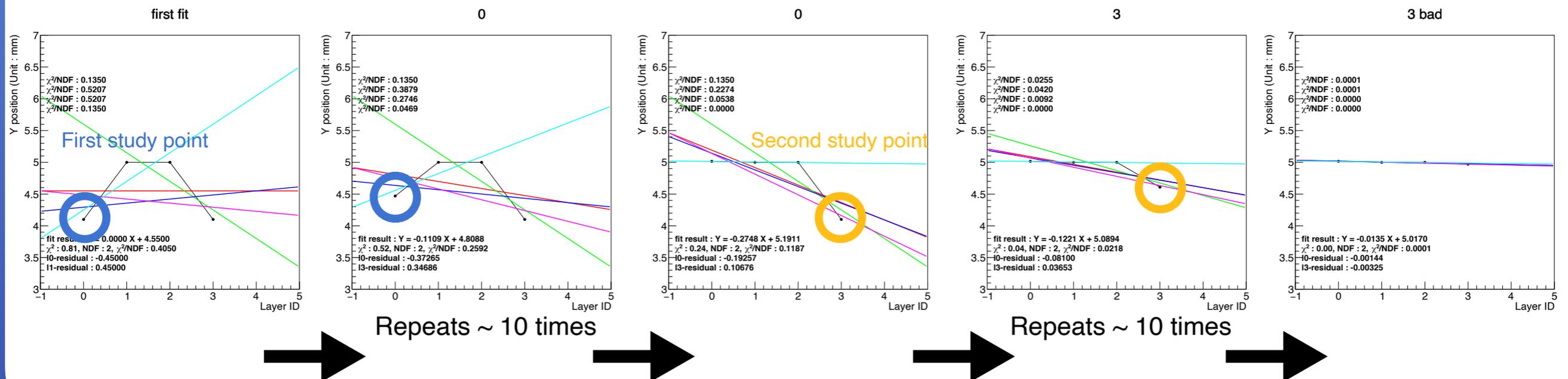
*****
*   Row   * Instance *  camac_adc *  camac_tdc * INTT_even *   module *  chip_id *  chan_id *   adc *      nele *      DSE *      eID *
*****
*   5855 *         0 *      45 *     165 *       1 *       2 *       5 *     29 *       3 *       1 *       0 *     5855 *
*   5855 *         1 *      99 *     140 *       1 *       *       *       *       *       1 *       0 *     5855 *
*   5855 *         2 *      94 *     145 *       1 *       *       *       *       *       1 *       0 *     5855 *
*   5855 *         3 *       *       0 *       1 *       *       *       *       *       1 *       0 *     5855 *
*   5855 *         4 *       *       0 *       1 *       *       *       *       *       1 *       0 *     5855 *
*   5855 *         5 *       *     909 *       1 *       *       *       *       *       1 *       0 *     5855 *
*****
    
```



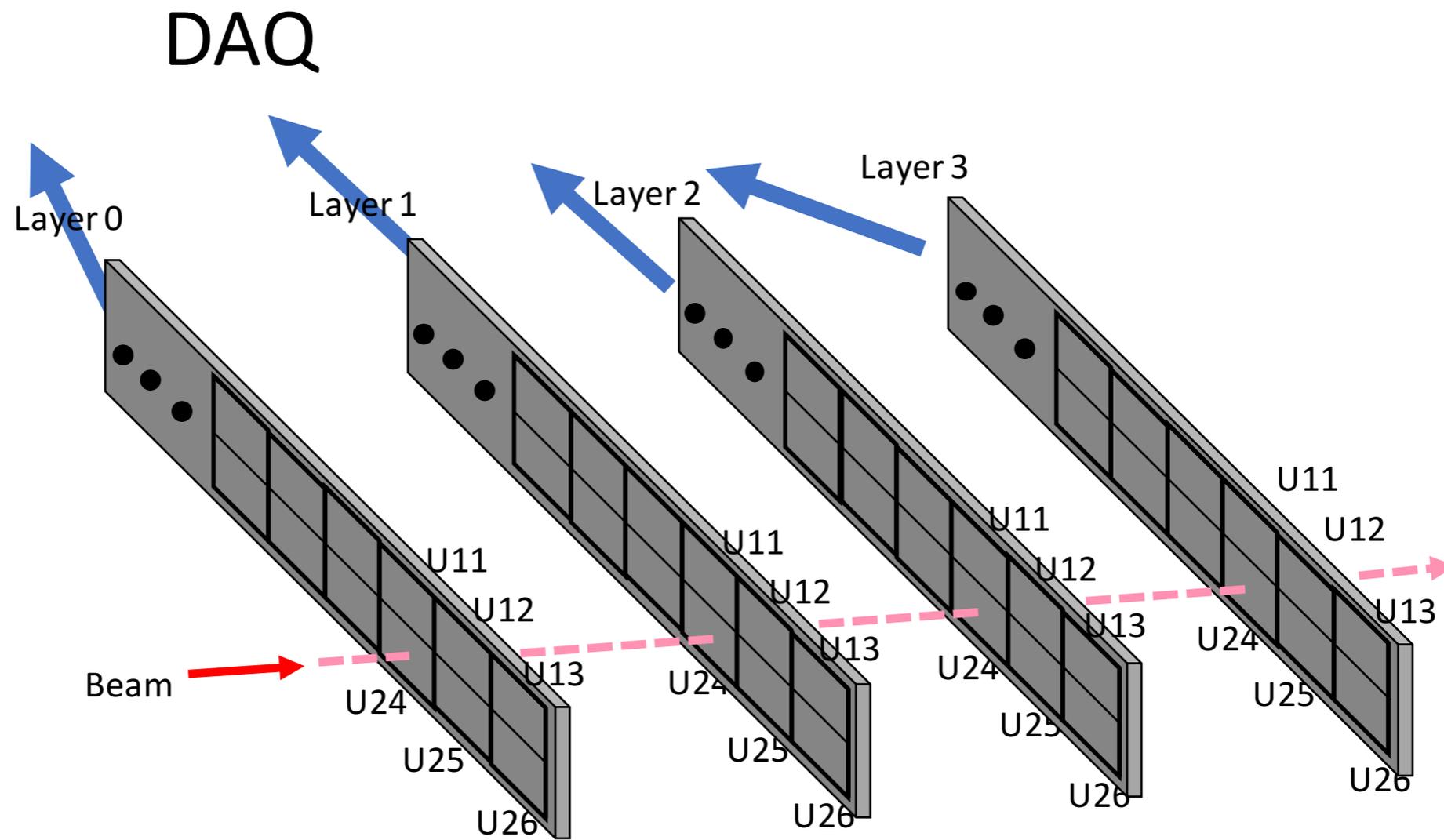
Alignment algorithm



- Only works on 4 layers Testbeam
 - Global fit (red line) : 4 points fitting line
 - 4 Local fits (rest color): 3 points fitting line
- The procedures to correct the layer position
 1. Find the point with largest residual (layer 0 in the example)
 2. Correct the point position by $0.3 \times$ original residual
 3. Fit the points again
 4. Check the new $r-\chi^2$ of Global fit and 4 local fits
 5. If all $r-\chi^2$ become smaller : calculate new residual, repeat action 2 and 3
 6. If one of $r-\chi^2$ becomes larger or residual $< 3\mu\text{m}$: stop, back to the previous position.
 7. Move to the next point



Current Testbeam setup in G4



Channel ID order

